

ERSI RISK AND UQ SUBCOMMITTEE ACTIVITIES

Virtual ERSI Workshop February 2022



Committee Overview

- **GOAL**: Investigate and implement UQ methods that enhance the overall understanding of how residual stress affects life prediction analyses
 - Uncertainty Quantification
 - How do we understand and describe the uncertainty and variability in the relevant parameters?
 - Sensitivity Analysis
 - What are the most significant variables in the ERS process?
 - How can we maximize/minimize the benefits/damages of these variables?

Committee Members

- Co-chairs: Juan Ocampo (StMU) and Laura Hunt (SwRI)
- Participating Organizations
 - Analytical Processes/Engineering Solutions (AP/ES)
 - Hill Engineering
 - Lockheed Martin
 - NRC Canada
 - SmartUQ
 - Southwest Research Institute
 - St. Mary's University (TX)
 - University of Pittsburgh
 - USAF

Statistics, UQ, and V&V References

- ASTM E739-10, "Standard Practice for Statistical Analysis of Linear or Linearized Stress-Life or Strain-Life Fatigue Data," American Society of Testing and Materials, 2015.
- ASTM E2586-19, "Standard Practice for Calculating and Using Basic Statistics," American Society of Testing and Materials, 2020 Revision.
- Efron, Hastie, Computer Age Statistical Inference, 2017 Free PDF
- ASME V&V 10 Standard for Verification and Validation in Computational Solid Mechanics

New Residual Stress Database

APES, Inc.

Residual Stress Database

- Old capabilities retained: visualization, library, search db, interpolations of multiple files.
- New capabilities
 - Filtering of over 15 new parameters (old (5): material, CX%, D, t, e/D. new (24): over/underload, pre-cycles, filled holes, pristine/aged, CX countersink process, etc.)
 - AFGROW .sd3 (Residual stress data) output (Export Lines)
 - Handles replicates

Residual Stress Database-Library & Visualization



Over 15 unique parameters added Entry Fields

ID#	Parameter	Description	Type	Dependencies		
1	mat	Material name	String	Required		
2	comments	Coupon information or other	String	Required		
3	thk	Thickness	Double	Required		
4	Dia	Diameter	Double	Required		
5	ed	Edge Distance	Double	Required		
6	pctCX	Percentage Cold Work	Double	Required		
7	cskProc1	Countersink process	String	10,11		
8	angle	Countersink angle	Double	Required		
9	depth	Countersink depth	Double	Required if 10 is not = 0, 7		
10	precycles	Number of pre-cycles	Integer	20 must be Yes, 11,12		
11	rvalue	R value	Double	20 must be Yes, 10,12		
12	smax	Pre-cycle load	Double	20 must be Yes, 10,11		
13	replicates	Replicate number out of a set	Integer.Integer	Required		
14	holeFilled	Boolean	Boolean	Required		
15	iff	Interference Fit during pre-cycle	Double	14 must be Yes		
16	overload	Overload as percentage of Yield	Double	14 must be Yes		
17	underload	Underload as a percentage of yield	Double	14 must be Yes		
18	sfh	Spectrum Flight Hours	Integer	19 must be Yes		
19	pristineAged	When cold work is performed on a pristine or aged material	Boolean	Required		
20	precrackB4CX	Existing pre-crack on coupon	Boolean	Required		
21	longdSplit	For specimens where longitudinal cut was made to compute RS	Boolean	Required		
22	sourceType	FEA (Finite Element Analysis), CM (Contour Method), EC (Eddy Current), ND (Neutron Diffraction), etc.	String	Required		

Filtering capability added

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7075-T651	1 (0.313	0.58	1.392	4	No	0	0	0	No	0	0.4	80				Overload	All		-21.7876
7075-T6	(0.19	0.25	0.45	4	No	0	0	0	No	0	0.4	5							-32.5257
7075-T651	1 (0.313	0.375	0.52125	4	No	0	0	0	No	0	0.5	2125				Underload	All		-2638
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Export to AFGROW readable residual stress file

Export Lines option



Export along angles or offset distances



Available, Free!

- Original database had 47 RS profiles
- 2021 update includes 323 RS profiles
 - User can add profiles
- For access, contact Scott Prost-Domasky: prost@apesolutions.com



Sensitivity Study on Cold Expanded Fastener Hole Damage Tolerance Life

A Collaborative ERSI Effort

Presented at the AFGROW Workshop 2021

Acknowledgements

Fatigue Technology Inc.

- Keith Hitchman
- Sam Zimmerman

USAF

- ► Jake Warner
- Hill Engineering
 - Dallen Andrew
 - Josh Hodges
- SwRI
 - Matt Kirby



What is Sensitivity Analysis?

- Sensitivity methods are analyses complementary to risk and uncertainty quantification that can help determine the impact of an input variable
- Sensitivity methods can have a tangible impact on analysis and testing
 - Save time
 - Save money
 - Spend time and money on characterizing the most important inputs



Data Flow

- Data flow through ERSI committees
 - Data gleaned from UQ/SA can inform all stages of the process



Specimen Geometry

- FTI has an ABAQUS model of their cold expansion process
- Two load steps: mandrel pull-through and reaming
- 0.5" aluminum plate thickness



From Hitchman and Zimmerman, "Development and Use of an FEA Script for Variance and Correlation Studies of Analytical Predictions of Cold Expansion Residual Stress Fields," HOLSIP 2016.



FTI Simulation Study

- FTI ran 29 samples of their cold expansion simulation ABAQUS model
- Results were provided to UQ and Analytical Methods Comms.
- Note that samples (except for sleeve thickness) were based on actual measurements, not from a distribution or DOE

Step 3: Input distributions



BAMpF Crack Growth Simulation

- Analytical Methods Committee used the resulting residual stress fields to grow a crack from an IFS of 0.05 in.
- Also ran cases with no RS from 0.05 and 0.005
- Note that most life benefit due to a compressive stress field happens below crack sizes of 0.05 inches
- However, since the initial flaw size of a DTA is associated with NDI capability, the initial flaw size remains the same despite the beneficial stress field



BAMpF Simulation

> Typical crack front with residual stress included





Correlation Matrix

		Elongation	Mandrel	Sleeve	Applied	Ultimate	Yield	Life
	Starting D	Elongation	Diameter	Thickness	Expansion	Strength	Strength	LIIE
Starting D	1.00	-0.02	0.02	-0.11	-0.61	0.15	0.09	-0.56
Elongation	-0.02	1.00	0.15	0.14	0.17	0.60	0.74	0.14
Mandrel Diameter	0.02	0.15	1.00	0.03	0.52	-0.22	-0.10	0.34
Sleeve Thickness	-0.11	0.14	0.03	1.00	0.67	-0.11	0.00	0.79
Applied Expansion	-0.61	0.17	0.52	0.67	1.00	-0.26	-0 10	0.95
Ultimate Strength	0.15	0.60	-0.22	-0.11	-0.26	1.00	0.80	-0.22
Yield Strength	0.09	0.74	-0.10	0.00	-0.10	0.80	1.00	-0.09
Life	-0.56	0.14	0.34	0.79	0.95	-0.22	-0.09	1.00

Applied Expansion (Ia) is given by the following formula:

 $I_a = \frac{(D + 2t - SHD)}{SHD} \times 100\%$

Reality Check

- Life is strongly correlated to applied expansion
- Yield is positively correlated to Ultimate
- Applied expansion is inversely correlated to starting hole diameter

Where:

D = Major Mandrel Diameter t = Sleeve Thickness SHD = Starting Hole Diameter



Scatter Plots

- All variables vs. Life
- High correlation between Applied expansion and Life
- Low correlation between Yield/Ultimate and Life
 - Sensitivity studies of RS fields found high correlation between material properties and outputs of interest
 - Emphasizes importance of defining the intended use of models



Global Sensitivities

- Calculated sensitivities on the linear reduced model using NESSUS
 - Note that main and total effects are the same due to linear model
- Sleeve thickness dominates, however,
 - small sensitivities could be due to unstructured sampling



Recommended Future Studies

- Rerun FTI models using a structured sampling method, such as Latin Hypercube
- Do more detailed studies between RS fields and Life to determine a proper metric for RS fields
- Compare results of BAMpF vs. regular AFGROW 2-pt models



Activities for Upcoming Year

- Perform risk calculations for crack growth simulations in the presence of residual stresses.
- Sensitivity and parametric study
- Provide support to other subcommittees as needed.